Searcn Notes						

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/537,393	GUO ET AL.	
Examiner	Art Unit	
David H. Kruse	1638	

SEARCHED			
Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NO (INCLUDING SEARCH		
	DATE	EXMR
Inventor Name Search	10/12/2007	/DK/
EAST USPAT, USPGPUB, EPO, JPO, Derwent	10/12/2007	/DK/
STN Agricola, Biosis, CaPlus, Embase	10/12/2007	/DK/
Sequence Search SEQ ID NO: 1, 2 and 3 Including interference search	8/4/2007	/DK/
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